

<b>Notice of References Cited</b>	Application/Control No. 10/711,117		Applicant(s)/Patent Under Reexamination VANDER BAAN, GABRIEL S.	
	Examiner LEE D. WILSON		Art Unit 3723	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,131,237 A	10-2000	Kasper et al.	15/320
*	B	US-6,158,081 A	12-2000	Kasen et al.	15/320
*	C	US-6,167,587 B1	01-2001	Kasper et al.	15/320
*	D	US-6,192,548 B1	02-2001	Huffman, Eric C.	15/320
*	E	US-6,230,362 B1	05-2001	Kasper et al.	15/320
*	F	US-2001/0022010 A1	09-2001	Kasper, Gary A.	15/320
*	G	US-6,286,181 B1	09-2001	Kasper et al.	15/320
*	H	US-6,401,294 B2	06-2002	Kasper, Gary A.	15/320
*	I	US-6,412,141 B1	07-2002	Kasper et al.	15/320
*	J	US-6,438,793 B1	08-2002	Miner et al.	15/320
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.